

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/808,468	MURAYAMA ET AL.	
Examiner	Art Unit	
Stevan A. Resan	1773	

SEARCHED							
Class	Subclass	Date	Examiner [.]				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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